

800™ TS

Absorbance Microplate Reader

GENERAL	GENERAL	
Detection modes	Absorbance	
Read methods	End point, kinetic and well area scanning (under computer control)	
Microplate types	6-, 12-, 24-, 48-, 96-well microplates 384-well microplates, (NB configurations) Maximum plate height 0.9" (22.86 cm)	
Other labware	Terasaki trays (NB configurations)	
Temperature control	Ambient +6 °C to 50 °C (800TSI) Ambient +8 °C to 50 °C (800TSUVI)	
Shaking	Linear (except NB configurations)	
User interface	4.3" color LCD touchscreen display	
Onboard software	 Up to 40 user-programmable protocols Quick menu Create, edit or run protocols Save results to USB thumb drive 	
Software	Gen5 [™] Software for external computer control and data analysis (optional)	
Connectivity	(1) USB Type B for computer control (2) USB Type A for thumb drive and printer	
ABSORBANCE		
Light source	Tungsten halogen lamp	
Wavelength selection	Filters	
Wavelength range	400 – 750 nm 340 – 750 nm (UV configurations)	
Bandwidth	10 nm	
Filter capacity/supplied	5 positions/4 (5 with UV configurations)	
Dynamic range	0 to 4.0 OD (normal & rapid read modes) 0 to 3.0 OD (sweep mode)	
Resolution	0.001 OD (standalone mode) 0.0001 OD (under Gen5 control)	

OD accuracy	800TS/800TSI Normal: ±1.0% ±0.010 OD from 0.0 to 2.0 OD @ 405 nm Rapid: ±2.0% ±0.020 OD from 0.0 to 2.0 OD @ 405 nm Sweep: ±1.0% ±0.020 OD from 0.0 to 1.0 OD @ 405 nm
	800TSUV & 800TSUVI Above 400 nm, accuracy specs are the same as 800TS/800TSI Normal (340-399 nm): ±2.0% ±0.010 OD from 0.0 to 2.0 OD @ 340nm Rapid (340-399 nm): ±2.5% ±0.020 OD from 0.0 to 2.0 OD @ 340nm
	80TSNB Normal: ±1.0% ±0.010 OD from 0.0 to 2.0 OD @ 405 nm Rapid: ±2.0% ±0.020 OD from 0.0 to 2.0 OD @ 405 nm
OD linearity	800TS/800TSI Normal: ±1.0% ±0.010 OD from 0.0 to 2.0 OD @ 405 nm,
	800TSUV/800TSUVI Above 400 nm, linearity specs are the same as 800TS/800TSI Normal (340-399 nm): ±2.5% ±0.010 OD from 0.0 to 2.0 OD @ 340nm Rapid (340-399 nm): ±2.5% ±0.010 OD from 0.0 to 2.0 OD @ 340nm
	800TSNB Normal: ±1.0% ±0.010 OD from 0.0 to 2.0 OD at 405 nm ±3.0% ±0.010 OD from 2.0 OD to 3.0 OD @ 450 nm Rapid: ±2.0% ±0.010 OD from 0.0 to 2.0 OD @ 405 nm
OD repeatability	800TS/800TSI Normal: ±0.5% ±0.005 OD from 0.0 to 2.0 OD @ 405 nm Rapid: ±1.0% ±0.010 OD from 0.0 to 2.0 OD @ 405 nm Sweep: ±2.0% ±0.010 OD from 0.0 to 1.0 OD @ 405 nm
	800TSUV/800TSUVI Above 400 nm, repeatability specs are the same as 800TS/800TSI Normal (340-399 nm): ±1.5% ±0.005 OD from 0.0 to 2.0 OD @ 340nm Rapid (340-399 nm): ±2.0% ±0.020 OD from 0.0 to 2.0 OD @ 340nm
	800TSNB For 96-well plates, repeatability specs are the same as 800TS/800TSI Normal (384-well): ±1.5% ±0.010 OD from 0.0 to 2.0 OD @ 405nm Rapid (384-well): ±2.0% ±0.010 OD from 0.0 to 2.0 OD @ 405 nm
Read speed	96 wells, single wavelength Normal read mode: 30 seconds Rapid read mode: 18 seconds Sweep read mode: 11 seconds
	96 wells, dual wavelength Normal read mode: 63 seconds

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PHYSICAL CHARACTERISTICS		
Connectivity	USB for external PC control USB for optional printer USB for peripheral devices	
Power	100 – 240 VAC, 50/60 Hz	
Dimensions	16.5"D x 15"W x 7"H (41.9 x 38.1 x 17.8 cm)	
Weight	18.5 lbs (8 kg)	
REGULATORY		
Regulatory	In Vitro Diagnostic models are available. CE and TUV marked, RoHS compliant.	

Specifications are subject to change. Performance specification values represent the average observed factory test values.

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